

**Notice of References Cited**Application/Control No.  
**09/982,538**Applicant(s)/Patent Under Reexam  
**Faure et al.**Examiner  
**Gail Verbitsky**Art Unit  
**2859**

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*		Document Number	Date	Name	Classification <sup>2</sup>	
		Country Code-Number-Kind Code	MM-YYYY <sup>1</sup>			
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**NON-PATENT DOCUMENTS**

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